

<b>Notice of References Cited</b>	Application/Control No. 10/728,520	Applicant(s)/Patent Under Reexamination DELGAUDIO ET AL.	
	Examiner John Shin	Art Unit 3687	Page 1 of 1

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*	B	US-2005/0055357 A1	03-2005	Campbell, Scott	707/100
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**NON-PATENT DOCUMENTS**

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